_	 SII IVC	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/903,583	ESAKI ET AL.	
Examiner	Art Unit	
Paul Nguyen-Ba	2176	

SEARCHED			
Class	Subclass	Date	Examiner
715	500.1 513	10/14/2005	PNB
707	100 102	10/14/2005	PNB
			<u> </u>
<u></u>			
,			
		<u> </u>	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		<u> </u>	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPAT US-PGPUB EPO JPO DERWENT IBM_TDB	10/14/2005	PNB
NPL SEARCH - ACM IEEE	10/14/2005	PNB